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# Improving the photovoltaic performance of planar heterojunction perovskite solar cells by mixed solvent vapor treatment†

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The grain size of perovskite films is a key factor to optimize the performance of perovskite photovoltaic devices. Herein, a new route is developed in this paper to prepare CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub> (MAPbI<sub>3</sub>) films with a better morphology and crystallization. This method includes the spin coating deposition of perovskite films with a precursor solution of PbI<sub>2</sub> and CH<sub>3</sub>NH<sub>3</sub>I at the molar ratio 1 : 1 and thermal annealing (TA). The thermal annealing is conducted with a thermal-induced process to realize grain growth with solvent evaporation. In addition, a mixed solvent vapor treatment in acetic acid with chlorobenzene (HAc/CB) improves the morphology and crystallization of films further. As a result, the photovoltaic device based on the perovskite film treated by mixed HAc/CB solvent exhibits the best efficiency of 13.15% in comparison to the control device with 11.44% under AM 1.5G irradiation (100 mW cm<sup>-2</sup>).

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## Introduction

The hybrid organolead halide perovskite solar cells (PSCs) have attracted much attention due to their controlled composition, lower-cost organic components, high charge carrier mobility properties,<sup>1,2</sup> extremely low trap-state density,<sup>3</sup> lesser exciton binding energy,<sup>4</sup> longer charge carrier diffusion length<sup>5,6</sup> and excellent absorption coefficient.<sup>7</sup> At present, the power conversion efficiencies (PCE) of PSCs has increased rapidly to 22.1% since perovskite solar cells were first reported in 2009.<sup>8,9</sup> PSCs have offered a promising route to fabricate solar cells *via* low-cost manufacturing process compared with traditional thin-film photovoltaic cells such as CIGS solar cells,<sup>10</sup> which are the new comers of the third-generation photovoltaic devices. Several typical technique processes to fabricate PSCs have been developed recently, including the solution-processed method,<sup>11–13</sup> the vacuum vapor phase deposition<sup>14</sup> and other combination thereof.<sup>15</sup> Compared with other methods, the solution process has great advantages due to the simple process and the low deposition equipment costs.

Furthermore, the solvent engineering has been proven to be a resultful deposition technology to enhance the grain size and uniform perovskite layers.<sup>16–20</sup> Sang II Seok *et al.* declared that dimethyl sulfoxide (DMSO) served as a cosolvent with the

gamma-butyrolactone (GBL) solution dissolving CH<sub>3</sub>NH<sub>3</sub>I (MAI) and PbI<sub>2</sub> *via* one-step spin coating method,<sup>21</sup> which boot the dissolubility of perovskite precursor and form dense films. Subsequently, they kept meliorating the techniques by a method with direct intramolecular exchange of DMSO molecules intercalated in PbI<sub>2</sub> involving formamidinium iodide (FAI) *via* a sequential two-step coating method.<sup>22</sup> Then they further elucidated that DMSO strongly interacts with DMSO and PbI<sub>2</sub>, and retard crystallization of the perovskite films. As we all known, a few polar organic molecules (*e.g.* DMSO, DMF) easily were absorbed into the perovskite materials.<sup>23,24</sup> The residual solvent in perovskite films dramatically destroy the crystal structure, which accelerated the ion migration and lattice deformation on account of charges accumulation and then weaken the stability of the perovskite layers.<sup>25</sup> A long time and high temperature annealing process would remove the residual molecules at the cost of losing counter ions in the surface, which increases the thin film defect and shortens the perovskite device performance.<sup>26</sup> Seok *et al.* applied the toluene drip-casting treatment during the spinning in one-step process.<sup>21</sup> Instead of toluene, Nam-Gyu Park *et al.* account that diethyl ether was a more advisable to remove DMSO and DMF solvent.<sup>27</sup> Nevertheless, either annealing process or diethyl ether treatment could not entirely remove the residual DMSO and FAI(MAI)-DMSO species.<sup>28</sup> The solar cells would explicitly deteriorate because that the residuary solvent induced the degradation of perovskite layers.<sup>29</sup> It is an intractable issue to remove the remnant solvent involved in the preparation process of thin films, especially the solvent still remained in the films after thermal annealing. However, it has not been investigated with

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respect to the PSCs performance so far for the effect of solvent treatment after thermal annealing of perovskite films.

Here, we investigated the PSCs performance with the solvent vapour treatment after the thermal annealing (TA). The  $\text{CH}_3\text{NH}_3\text{PbI}$  ( $\text{MAPbI}_3$ ) film preparing process involved one step deposition through perovskite precursor solution and acetic acid (HAc) with chlorobenzene (CB) mixed solvent vapor treatment process (H/CVT), which could effectively increase the crystallinity and improve the morphology quality. The films prepared based on H/CVT process were characterized by the scanning electron microscope (SEM), the X-ray diffraction (XRD) and time-resolved photoluminescence (PL) decay curves, in comparison with the films with prepared only by one-step thermal annealing (TA) processes. Then the photovoltaic devices were prepared and the dependence of their performance were discussed in the various process conditions. The fabricated photovoltaic devices based H/CVT process exhibited the best PCE up to 13.15% under AM 1.5G radiation ( $100 \text{ mW cm}^{-2}$ ) and in comparison to control devices with a 14.9% improvement.

## Experimental

### Materials

$\text{PbI}_2$  and  $\text{CH}_3\text{NH}_3\text{I}$  were purchased from Xi'an Polymer Light Technology Corp. Acetic acid (HAc, purity > 99.99%) and chlorobenzene (CB) were purchased from Sigma-Aldrich. PCBM was purchased from Nano-C. The precursor solution of  $\text{CH}_3\text{NH}_3\text{PbI}_3$  was composed of  $\text{PbI}_2$  and  $\text{CH}_3\text{NH}_3\text{I}$  with a molar ratio of 1 : 1 and was stirred in a mixture of dimethyl sulfoxide (DMSO) and  $\gamma$ -butyrolactone (GBL) (3/7, v/v) at  $60^\circ\text{C}$  overnight. Phenyl-C61-butyric acid methyl ester (PCBM) was dissolved in *o*-dichlorobenzene with a concentration of  $20 \text{ mg ml}^{-1}$ .

### Solar cells fabrication and characterization

All the solar cells were fabricated on indium tin oxide (ITO)-coated glass substrates. The ITO substrates were consecutively cleaned in ultrasonic baths containing glass lotion, de-ionized water, ethanol. The cleaned ITO substrates were then blow-dried by nitrogen gas. All pre-cleaned ITO substrates were treated by UV-ozone cleaner for 10 min to improve work function and then transferred into a nitrogen-filled glove box. The filtered PEDOT:PSS (Clevios, Al4083) was coated on ITO glass substrates by spin-coating at 4000 round per minute (rpm) for 40 s and annealed at  $120^\circ\text{C}$  for 20 min. The perovskite precursor solution was deposited onto ITO/PEDOT:PSS substrates by a consecutive two-step spin-coating process as described in previous reports,<sup>21</sup> but using chlorobenzene as an anti-solvent. The as-deposited perovskite films were heat treated with TA and H/CVT process respectively. For the TA process, the perovskite precursor coated substrates were dried onto a hot plate at  $100^\circ\text{C}$  for 5 min. For the H/CVT process the perovskite film heat treated through TA process was continued treating under thermal condition at  $70^\circ\text{C}$  for 3 min in glove-box. For the H/CVT process, the perovskite film were put into Petri dishes (with cover but not sealed) with vapor of mixed

solvents of HAc and CB with defined volume ratios (1/50, 1/25, 3/50, v/v). The substrates were treated under thermal condition at  $70^\circ\text{C}$  without touching the mix-solvent. Afterwards, the PCBM layer was then spin-coated onto the  $\text{CH}_3\text{NH}_3\text{PbI}_3$  layer at 1500 rpm for 60 s. Finally, the devices were finished by thermal evaporating Al (80 nm) under  $4 \times 10^{-4} \text{ Pa}$  vacuum condition. The device area is defined to be the overlap of the ITO and Al electrodes to be  $4 \text{ mm}^2$ .

The current density–voltage ( $J$ – $V$ ) curves of the devices were measured with a source meter (Keithley 2400) and measurement unit under simulated AM 1.5G sun spectrum with  $100 \text{ mW cm}^{-2}$  irradiation generated by an ABET Sun 2000 solar simulator in air. External quantum efficiency (EQE) was measured by Zolix Solar Cell Scan 100. Ultraviolet-visible absorption spectra were tested on a Shimadzu UV-3101PC spectrophotometer in the 400–800 nm wavelength range at room temperature. All characterizations were done outside the glovebox and without any encapsulation of the perovskite cells, under constant exposure to ambient atmosphere. Steady-state photoluminescence (PL) spectra were recorded by Horiba FluoroLog Spectrophotometer. PL measurements of the perovskite films were covered with a polymethyl methacrylate (PMMA) layer to prevent degradation from ambient atmosphere. Scanning electron microscope (SEM) measurements were performed using a Hitachi, S-4800 SEM equipped with the energy dispersive X-ray spectrum. X-ray diffraction (XRD) spectra was performed on a D/max 2200v X-ray powder diffractometer equipped with Cu-K $\alpha$  radiation ( $\lambda = 1.540 \text{ \AA}$ ), the data were collected at room temperature in the range of  $10$ – $50^\circ$ .

## Results and discussion

Fig. 1 illustrates the preparation procedure of the  $\text{CH}_3\text{NH}_3\text{PbI}_3$  ( $\text{MAPbI}_3$ ) perovskite films in our research. The pristine perovskite films firstly were prepared based on the study of Seo *et al.*,<sup>17</sup> in which non-polar solvent chlorobenzene (CB) was dripped onto the substrates surface during spinning. Afterwards, the substrates were transferred onto the heated platform, the perovskite films turn into dark brown quickly. For the H/CVT process, the perovskite films were subjected to the post-heating treatment, then the perovskite films were put into a Petri dish with the vapor of mixed solvents of HAc and CB.  $15 \mu\text{L}$  mixed solvent was dripped into the Petri dish edge, the as-samples were covered by a glass Petri dish rapidly (with cover

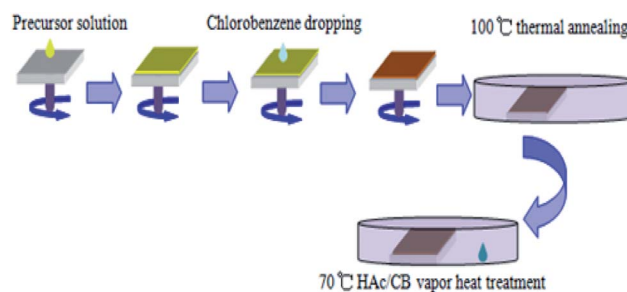


Fig. 1 Schematic diagram of the thermal treatment of perovskite films under solvent vapor.



but not sealed). The perovskite films were annealed by the mixed solvent of HAC/CB with various volume ratios of HAC (1/50, 1/25, 3/50, v/v). The architecture of the p-i-n PSC with ITO/PEDOT:PSS/MAPbI<sub>3</sub>/[6,6]-phenyl-C61-butyric acid methyl ester (PCBM)/Al is schematically shown in Fig. 2(a) and the corresponding energy levels of each layer are shown in Fig. 2(b). The control device with the same structure was also fabricated for the comparison without HAC/CB mixing vapor treatment. The *J*-*V* characteristic curves of the PSCs of various process conditions are shown in Fig. 3. In addition, the average values of the device parameters obtained from 8 PSCs in each experimental group, which are extracted from the *J*-*V* curves are listed in Table 1. According to the photovoltaic performance (Fig. 3 and Table 1), the vapor treatment level for the highest PCE is 1/25 volume ratio of HAC. In order to further investigate the mechanism of the enhanced performance of PSCs with HAC thermal treatment, the superior mixing ratio of 1/25 volume ratio is used in this study. The control group without using HAC/CB mixing vapor treatment has a PCE of 11.44%, which is similar to the values obtained in previous studies for this structure.<sup>18,30,31</sup> The maximum improvement in PCE is obtained when 1/25 volume ratio mixed HAC/CB solvent was used. In this case, the median PCE value increases from 11.44% to 13.15%, corresponding to a 14.9% improvement. This improvement in PCE is primarily due to the 7.1% enhancement of *J*<sub>sc</sub>, which increases from 15.38 to 16.47 mA cm<sup>-2</sup>, as shown in Fig. 3 and Table 1. To be fair, our champion control device is 12.05%, which reveals that our control cells show performance comparable to the results reported in Table 2.<sup>17,32-36</sup>

To investigate the main reason responsible for the improvement of *J*<sub>sc</sub>, we conduct external quantum efficiency (EQE) measurements to account for the contribution of photocurrent collection to the incoming photon energy. The EQE spectra illustrates a substantial improvement across the visible region when the H/CVT process applied as shown in Fig. 4(a). We ascribe the enhancement at the 400 to 800 nm to the stronger absorption of the MAPbI<sub>3</sub> film shown in Fig. 4(b). The H/CVT films demonstrate a strong absorption in the range between 400 and 780 nm with an onset absorption at 800 nm, which corresponds to a bandgap of 1.55 eV. The more intense absorption of the films with the acetic acid vapor thermal treatment should also be partially attributed to the more homogenous morphology, which are supported by SEM images of the films discussed later. The EQE measurement of two PSCs follows the same trend of the UV-vis absorption spectra.<sup>37</sup> The

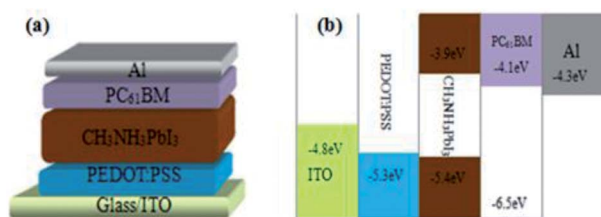


Fig. 2 (a) Schematic device architecture of the p-i-n PSCs constructed by ITO/PEDOT:PSS/CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub>/PCBM/Al; (b) schematic energy band diagram of perovskite solar cells.

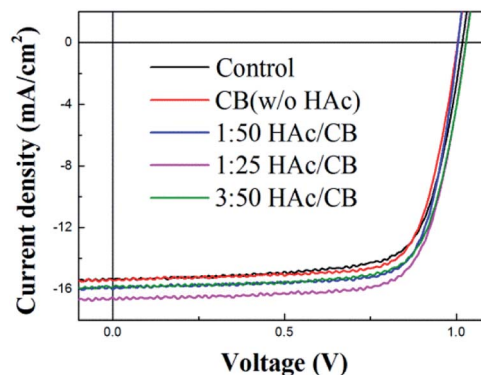


Fig. 3 *J*-*V* characteristics of MAPbI<sub>3</sub> devices with HAC mixing different volume ratios under 100 mW cm<sup>-2</sup> (AM 1.5G).

Table 1 Photovoltaic parameters of devices by thermal treatment of the mixed HAC/CB solvent with different volume ratios conditions. Average PCE values were based on 8 devices of each type

Treatment type	<i>J</i> <sub>sc</sub> (mA cm <sup>-2</sup> )	<i>V</i> <sub>oc</sub> (V)	FF (%)	PCE <sub>average</sub> (%)	PCE <sub>best</sub> (%)
Control	15.38	1.02	73	11.44 ± 0.52	12.05
With CB (w/o HAC)	15.46	1.01	75	11.64 ± 0.42	12.17
1 : 50 HAC with CB	16.13	1.01	75	12.41 ± 0.31	12.88
1 : 25 HAC with CB	16.47	1.03	75	12.80 ± 0.30	13.15
3 : 50 HAC with CB	15.93	1.03	75	12.24 ± 0.30	12.61

EQE is product of light harvesting efficiency, charge injection/transfer efficiency, and charge collection efficiency. The light harvesting efficiency is higher in the experimental condition of H/CVT films than the control device, indicating that H/CVT will contribute to the higher photo-to-electron conversion efficiency. The improvement of film quality is favourable to the charge transport and the light absorption, than the highest *J*<sub>sc</sub> of the 1/25 volume ratios H/CVT device was achieved. Each device shows almost same values of *V*<sub>oc</sub>, which is plausible as *V*<sub>oc</sub> determined by the difference between the electron quasi-Fermi level of n-type semiconductor (PCBM in our device) and hole quasi-Fermi level of p-type semiconductor (PEDOT:PSS in our device).<sup>38</sup>

An excitation light of 505 nm falls on the glass/MAPbI<sub>3</sub> film without and with various volume ratio HAC/CB mixing vapor treatment from the air side, and the photoluminescence (PL)

Table 2 Photovoltaic performance of perovskite solar cells with device architecture of ITO/PEDOT:PSS/CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub>/PCBM/Al in some reported works

<i>J</i> <sub>sc</sub> (mA cm <sup>-2</sup> )	<i>V</i> <sub>oc</sub> (V)	FF (%)	PCE <sub>average</sub> (%)	PCE <sub>best</sub> (%)	Ref.
16.62	0.92	80	11.80	12.20	17
18.02	0.85	75	11.43	—	32
19.12	0.87	73	11.62	12.13	33
18.6	0.92	72	—	12.30	34
19.2	0.85	71	11.50	—	35
16.12	1.05	67	—	12.04	36



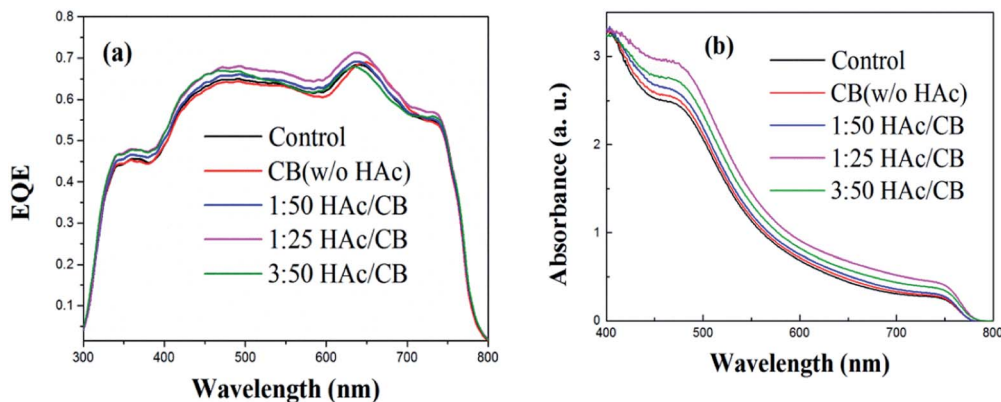


Fig. 4 (a) EQE spectra of devices treated without and with different volume ratios HAC/CB (b) UV-vis absorption spectra of MAPbI<sub>3</sub> film were treated without and with various volume ratios HAC/CB.

signal was also collected from the air side to compared the film quality. All samples exhibit a PL peak at 766 nm in Fig. 5(a), which is in agreement with the data reported elsewhere.<sup>32,39</sup> Generally, the photoluminescence emission is related to the charge carrier recombination of the bandgap and trap states. The phenomenon may imply the perovskite thin film under H/CVT process has a lower trap density around the band-edge than the control film due to the relative high intensity of PL, which is expected to reduce the recombination loss and improve the photocurrent collection. Meanwhile, we measured the time-resolved PL decay curves of a glass/MAPbI<sub>3</sub> film without and with various volume ratio HAC/CB mixing vapor treatment as shown in Fig. 5(b). From the deconvolution of the time-resolved PL decays with a tri-exponential function, the average PL lifetime of 1/25 volume ratios H/CVT film (~118.25 ns) is longer than that of control film (~93.12 ns) as listed in Table 3, which

is comparable to the value found in MAPbI<sub>3</sub> film in previous reports.<sup>39</sup> The faster PL quenching in the control film than in the H/CVT film confirms that the recombination loss of the charge carriers in the control film is more than that of H/CVT film. It indicates the improved H/CVT film suppresses the nonradiative recombination channels.

The variation of the carrier recombination in PSCs also correlates with the crystallization property of the perovskite thin films. Hence, the scanning electron microscope (SEM) images and X-ray diffraction (XRD) spectroscopy of MAPbI<sub>3</sub> thin films without and with H/CVT process were measured. The crystallization of the MAPbI<sub>3</sub> film is a crucial parameter, which is correlated to the light-absorption ability, charge transport and recombination properties of PSCs. The large grain size and good crystallinity will lead to a high performance of the resulting devices.<sup>40</sup> Fig. 6(a) shows the X-ray diffraction (XRD) spectroscopy of the MAPbI<sub>3</sub> film treated by 1/25 volume ratio HAC/CB mixing solvent and without, respectively. With the similar film thickness and under the same measurement condition, the diffraction peak intensity (110) of the MAPbI<sub>3</sub> film processed with HAC vapor treatment is higher than that of the MAPbI<sub>3</sub> film without HAC treatment. In general, XRD peak intensity is related to the crystal orientation and surface porosity. The XRD spectra present intense diffraction peaks at 14.50°, 28.84°, and 32.28° in two samples, corresponding to (110), (220), and (310) crystal planes of MAPbI<sub>3</sub>,<sup>41</sup> respectively. SEM images shown in Fig. 6(b)–(f) reveal an interesting phenomena that the grain size

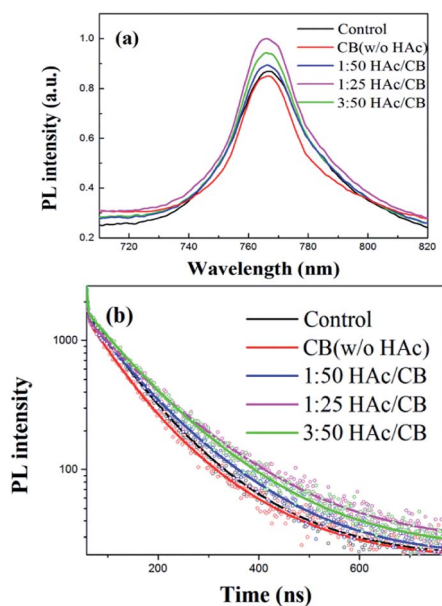


Fig. 5 (a) Steady-state photoluminescence spectra of MAPbI<sub>3</sub> film coated on glass substrate; (b) time-resolved photoluminescent decay curves of glass/MAPbI<sub>3</sub> film were treated without and with various volume ratios HAC/CB.

Table 3 Time resolved photoluminescence decay characterization

Treatment type	$\tau_1$ (ns)	Fraction 1	$\tau_2$ (ns)	Fraction 2	$\tau_3$ (ns)	Fraction 3	Average (ns)
Control	1.00	3.34%	65.92	55.64%	137.52	41.02%	93.12
With CB (w/oHAc)	1.05	4.45%	60.88	50.79%	139.19	44.76%	93.26
1 : 50 HAC with CB	1.06	3.60%	67.39	40.82%	137.22	55.58%	103.81
1 : 25 HAC with CB	1.06	3.12%	67.81	26.91%	142.97	69.93%	118.25
3 : 50 HAC with CB	0.97	2.87%	71.50	40.92%	143.38	56.21%	109.88



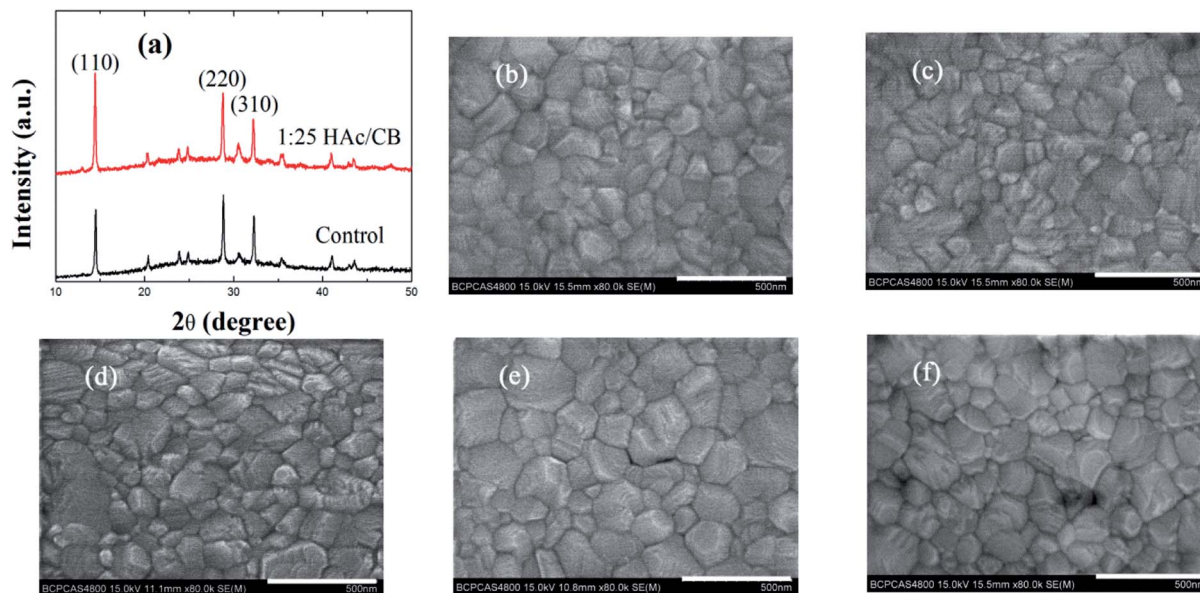


Fig. 6 (a) XRD patterns of MAPbI<sub>3</sub> films were treated without and with 1/25 volume ratios HAC/CB, respectively; (c) SEM image of the MAPbI<sub>3</sub> film prepared with CB vapor treatment; (b), (d), (e) and (f) SEM images of MAPbI<sub>3</sub> films prepared without and with 1/50, 1/25, 3/50 volume ratios HAC/CB, respectively, scale bar is 500 nm.

of the perovskite film with HAC/CB mixed solvent treatment is larger than that only annealing processes. Extremely the MAPbI<sub>3</sub> film of 1/25 volume ratios HAC/CB mixing solution shows a larger grain, which is comparable to other treated films. The average MAPbI<sub>3</sub> grain size of the film treated with 1/25 H/CVT and only TA is circa 160 nm and 130 nm, respectively. Using nano measurer software, we assess the maximum grain size of MAPbI<sub>3</sub> film treated with 1/25 H/CVT and only TA is 360 nm and 310 nm, respectively. The enlargement of the perovskite grain size reveals fewer grain boundaries which correlate to a lower trap density.<sup>2,35,39,42,43</sup> As the recombination in PSCs is evidenced to be governed by the trap states,<sup>44</sup> the larger grain size of the perovskite film with HAC/CB mixed solvent vapor treatment indicates less recombination. Hence, we can conclude that the large grain size of the perovskite thin films with HAC/CB mixed solvent treatment contribute to decrease the charge carrier recombination. This result is in accordance with the XRD patterns, and reveals that with HAC/CB mixed solvent treatment perovskite thin films are favor to the growth of large grain MAPbI<sub>3</sub> films.

## Conclusions

In summary, we have demonstrated a route to treat MAPbI<sub>3</sub> perovskite layers by mixed solvents with HAC and CB, which improves the photoelectric characteristic of the corresponding PSCs, and significantly boosts the devices efficiency ( $\approx 15\%$ ). The PSCs treated by 1/25 volume ratios H/CVT show a greater photocurrent and less charge carries non-radioactive recombination. We attribute the enhancements to the improved light absorption and the larger grain size that helps to reduce carries losses. This work provides the significant development potential of solvent vapor treatment process after the thermal

annealing of perovskite thin films, which emphasizes an effective strategy to facilitate the efficient device performance of the planar heterojunction PSCs toward practical applications in the future.

## Conflicts of interest

There are no conflicts to declare.

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## References

- 1 C. Wehrenfennig, M. Liu, H. J. Snaith, M. B. Johnston and L. M. Herz, *Energy Environ. Sci.*, 2014, 7, 2269–2275.
- 2 Z. Xiao, Q. Dong, C. Bi, Y. Shao, Y. Yuan and J. Huang, *Adv. Mater.*, 2014, 26, 6503–6509.
- 3 D. Shi, V. Adinolfi, R. Comin, M. Yuan, E. Alarousu, A. Buin, Y. Chen, S. Hoogland, A. Rothenberger and K. Katsiev, *Science*, 2015, 347, 519–522.
- 4 Q. Lin, A. Armin, R. C. R. Nagiri, P. L. Burn and P. Meredith, *Nat. Photonics*, 2015, 9, 106.
- 5 Q. Dong, Y. Fang, Y. Shao, P. Mulligan, J. Qiu, L. Cao and J. Huang, *Science*, 2015, 347, 967–970.
- 6 S. D. Stranks, G. E. Eperon, G. Grancini, C. Menelaou, M. J. Alcocer, T. Leijtens, L. M. Herz, A. Petrozza and H. J. Snaith, *Science*, 2013, 342, 341–344.



- 7 D. Yang, R. Yang, X. Ren, X. Zhu, Z. Yang, C. Li and S. F. Liu, *Adv. Mater.*, 2016, **28**, 5206–5213.
- 8 W. S. Yang, B.-W. Park, E. H. Jung, N. J. Jeon, Y. C. Kim, D. U. Lee, S. S. Shin, J. Seo, E. K. Kim and J. H. Noh, *Science*, 2017, **356**, 1376–1379.
- 9 A. Kojima, K. Teshima, Y. Shirai and T. Miyasaka, *J. Am. Chem. Soc.*, 2009, **131**, 6050–6051.
- 10 S. Kazim, M. K. Nazeeruddin, M. Grätzel and S. Ahmad, *Angew. Chem., Int. Ed.*, 2014, **53**, 2812–2824.
- 11 M. M. Lee, J. Teuscher, T. Miyasaka, T. N. Murakami and H. J. Snaith, *Science*, 2012, 1228604.
- 12 H.-S. Kim, C.-R. Lee, J.-H. Im, K.-B. Lee, T. Moehl, A. Marchioro, S.-J. Moon, R. Humphry-Baker, J.-H. Yum and J. E. Moser, *Sci. Rep.*, 2012, **2**, 591.
- 13 J. M. Ball, M. M. Lee, A. Hey and H. J. Snaith, *Energy Environ. Sci.*, 2013, **6**, 1739–1743.
- 14 M. Liu, M. B. Johnston and H. J. Snaith, *Nature*, 2013, **501**, 395.
- 15 Q. Chen, H. Zhou, Z. Hong, S. Luo, H.-S. Duan, H.-H. Wang, Y. Liu, G. Li and Y. Yang, *J. Am. Chem. Soc.*, 2013, **136**, 622–625.
- 16 L. Etgar, P. Gao, Z. Xue, Q. Peng, A. K. Chandiran, B. Liu, M. K. Nazeeruddin and M. Grätzel, *J. Am. Chem. Soc.*, 2012, **134**, 17396–17399.
- 17 J. Seo, S. Park, Y. C. Kim, N. J. Jeon, J. H. Noh, S. C. Yoon and S. I. Seok, *Energy Environ. Sci.*, 2014, **7**, 2642–2646.
- 18 P. W. Liang, C. Y. Liao, C. C. Chueh, F. Zuo, S. T. Williams, X. K. Xin, J. Lin and A. K. Y. Jen, *Adv. Mater.*, 2014, **26**, 3748–3754.
- 19 M. Yang, T. Zhang, P. Schulz, Z. Li, G. Li, D. H. Kim, N. Guo, J. J. Berry, K. Zhu and Y. Zhao, *Nat. Commun.*, 2016, **7**, 12305.
- 20 F. Xu, T. Zhang, G. Li and Y. Zhao, *ChemSusChem*, 2017, **10**, 2365–2369.
- 21 N. J. Jeon, J. H. Noh, Y. C. Kim, W. S. Yang, S. Ryu and S. I. Seok, *Nat. Mater.*, 2014, **13**, 897.
- 22 W. S. Yang, J. H. Noh, N. J. Jeon, Y. C. Kim, S. Ryu, J. Seo and S. I. Seok, *Science*, 2015, **348**, 1234–1237.
- 23 Q. Wang, Y. Shao, Q. Dong, Z. Xiao, Y. Yuan and J. Huang, *Energy Environ. Sci.*, 2014, **7**, 2359–2365.
- 24 N. Lin, J. Qiao, H. Dong, F. Ma and L. Wang, *J. Mater. Chem. A*, 2015, **3**, 22839–22845.
- 25 Y. Yuan and J. Huang, *Acc. Chem. Res.*, 2016, **49**, 286–293.
- 26 B. Conings, J. Drijkoningen, N. Gauquelin, A. Babayigit, J. D'Haen, L. D'Olieslaeger, A. Ethirajan, J. Verbeeck, J. Manca and E. Mosconi, *Adv. Energy Mater.*, 2015, **5**, 1500477.
- 27 N. Ahn, D.-Y. Son, I.-H. Jang, S. M. Kang, M. Choi and N.-G. Park, *J. Am. Chem. Soc.*, 2015, **137**, 8696–8699.
- 28 W. Li, J. Fan, J. Li, G. Niu, Y. Mai and L. Wang, *ACS Appl. Mater. Interfaces*, 2016, **8**, 30107–30115.
- 29 S. Pang, H. Hu, J. Zhang, S. Lv, Y. Yu, F. Wei, T. Qin, H. Xu, Z. Liu and G. Cui, *Chem. Mater.*, 2014, **26**, 1485–1491.
- 30 Q. Chen, H. Zhou, T.-B. Song, S. Luo, Z. Hong, H.-S. Duan, L. Dou, Y. Liu and Y. Yang, *Nano Lett.*, 2014, **14**, 4158–4163.
- 31 K. G. Lim, H. B. Kim, J. Jeong, H. Kim, J. Y. Kim and T. W. Lee, *Adv. Mater.*, 2014, **26**, 6461–6466.
- 32 D. Huang, T. Goh, J. Kong, Y. Zheng, S. Zhao, Z. Xu and A. D. Taylor, *Nanoscale*, 2017, **9**, 4236–4243.
- 33 X. Huang, K. Wang, C. Yi, T. Meng and X. Gong, *Adv. Energy Mater.*, 2016, **6**, 1501773.
- 34 X. Gong, M. Li, X. B. Shi, H. Ma, Z. K. Wang and L. S. Liao, *Adv. Funct. Mater.*, 2015, **25**, 6671–6678.
- 35 C. Bi, Q. Wang, Y. Shao, Y. Yuan, Z. Xiao and J. Huang, *Nat. Commun.*, 2015, **6**, 7747.
- 36 O. Malinkiewicz, A. Yella, Y. H. Lee, G. M. Espallargas, M. Graetzel, M. K. Nazeeruddin and H. J. Bolink, *Nat. Photonics*, 2014, **8**, 128.
- 37 Z. Zhu, Y. Bai, T. Zhang, Z. Liu, X. Long, Z. Wei, Z. Wang, L. Zhang, J. Wang and F. Yan, *Angew. Chem.*, 2014, **126**, 12779–12783.
- 38 B. Cai, Y. Xing, Z. Yang, W.-H. Zhang and J. Qiu, *Energy Environ. Sci.*, 2013, **6**, 1480–1485.
- 39 Y. Li, Z. Xu, S. Zhao, B. Qiao, D. Huang, L. Zhao, J. Zhao, P. Wang, Y. Zhu and X. Li, *Small*, 2016, **12**, 4902–4908.
- 40 W. Nie, H. Tsai, R. Asadpour, J.-C. Blancon, A. J. Neukirch, G. Gupta, J. J. Crochet, M. Chhowalla, S. Tretiak and M. A. Alam, *Science*, 2015, **347**, 522–525.
- 41 Q. Xue, Z. Hu, J. Liu, J. Lin, C. Sun, Z. Chen, C. Duan, J. Wang, C. Liao and W. M. Lau, *J. Mater. Chem. A*, 2014, **2**, 19598–19603.
- 42 Y. Shao, Y. Fang, T. Li, Q. Wang, Q. Dong, Y. Deng, Y. Yuan, H. Wei, M. Wang and A. Gruverman, *Energy Environ. Sci.*, 2016, **9**, 1752–1759.
- 43 J.-H. Im, I.-H. Jang, N. Pellet, M. Grätzel and N.-G. Park, *Nat. Nanotechnol.*, 2014, **9**, 927–932.
- 44 G. J. A. Wetzelaer, M. Scheepers, A. M. Sempere, C. Momblona, J. Ávila and H. J. Bolink, *Adv. Mater.*, 2015, **27**, 1837–1841.

